

**Search Notes**

Application/Control No.

10/784,165

Examiner

Ryan D. Walsh

Applicant(s)/Patent under  
Reexamination

KAMEI, CHIKASHI

Art Unit

2852

**SEARCHED**

Class	Subclass	Date	Examiner
399	33	7/15/2005	RDW
399	67	7/15/2005	RDW
399	69	7/15/2005	RDW
399	70	7/15/2005	RDW
399	96	7/15/2005	RDW
399	328	7/15/2005	RDW
399	330	7/15/2005	RDW

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East: See attached	7/15/2005	RDW
Consulted: Primary Examiner David Gray	7/15/2005	RDW